Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10717496	SAINT ETIENNE ET AL.	
Examiner	Art Unit	
Cehic, Kenan	2616	

SEARCHED				
Class	Subclass	Date	Examiner	
370	516,517,519,238,395.21,253,235,230,230.1,508,516,389	11/8/2007	KC	

SEARCH NOTES				
Search Notes	Date	Examiner		
Inventorship Search	11/5/2007	KC		
Consulted with SPE Kwang Yao	11/7/2007	KC		
EAST Text search	11/6/2007	KC		
IEEE Xplorer	11/8/2007	KC		

INTERFERENCE SEA	RCH	
Subclass	Date	Examiner
		INTERFERENCE SEARCH Subclass Date

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